

Rochester Electronics Manufactured Components

Rochester branded components are manufactured using either die/wafers purchased from the original suppliers or Rochester wafers recreated from the original IP. All recreations are done with the approval of the OCM.

Parts are tested using original factory test programs or Rochester developed test solutions to guarantee product meets or exceed the OCM data sheet.

Quality Overview

- ISO-9001
- AS9120 certification
- Qualified Manufacturers List (QML) MIL-PRF-35835
 - Class Q Military
 - Class V Space Level
- Qualified Suppliers List of Distributors (QSLD)
- Rochester is a critical supplier to DLA and meets all industry and DLA standards.

Rochester Electronics, LLC is committed to supplying products that satisfy customer expectations for quality and are equal to those originally supplied by industry manufacturers.

The original manufacturer's datasheet accompanying this document reflects the performance and specifications of the Rochester manufactured version of this device. Rochester Electronics guarantees the performance of its semiconductor products to the original OEM specifications. 'Typical' values are for reference purposes only. Certain minimum or maximum ratings may be based on product characterization, design, simulation, or sample testing.



Data Sheet April 29, 2010 FN2853.6

Dual Power MOSFET Driver

The ICL7667 is a dual monolithic high-speed driver designed to convert TTL level signals into high current outputs at voltages up to 15V. Its high speed and current output enable it to drive large capacitive loads with high slew rates and low propagation delays. With an output voltage swing only millivolts less than the supply voltage and a maximum supply voltage of 15V, the ICL7667 is well suited for driving power MOSFETs in high frequency switched-mode power converters. The ICL7667's high current outputs minimize power losses in the power MOSFETs by rapidly charging and discharging the gate capacitance. The ICL7667's inputs are TTL compatible and can be directly driven by common pulse-width modulation control ICs.

Ordering Information

PART NUMBER (Note)	PART MARKING	TEMP. RANGE (°C)	PACKAGE	PKG. DWG. #
ICL7667CBA*	7667 CBA	0 to 70	8 Ld SOIC (N)	M8.15
ICL7667CBAZA	7667 CBAZ	0 to 70	8 Ld SOIC (N) (Pb-Free)	M8.15
ICL7667CPA*	7667 CPA	0 to 70	8 Ld PDIP	E8.3
ICL7667CPAZ	7667 CPAZ	0 to 70	8 Ld PDIP* (Pb-Free)	E8.3

^{*}Add "-T" suffix for tape and reel. Please refer to TB347 for details on reel specifications.

NOTE: These Intersil Pb-free plastic packaged products employ special Pb-free material sets, molding compounds/die attach materials, and 100% matte tin plate plus anneal (e3 termination finish, which is RoHS compliant and compatible with both SnPb and Pb-free soldering operations). Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.

Features

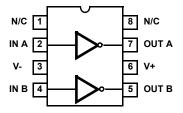
- · Fast Rise and Fall Times
 - 30ns with 1000pF Load
- · Wide 15V Supply Voltage Range
 - V+ = +4.5V to +15V
 - V- = -15V to Ground (0V)
- Low Power Consumption
 - 4mW with Inputs Low
 - 20mW with Inputs High
- · TTL/CMOS Input Compatible Power Driver
 - $R_{OUT} = 7\Omega$ Typ
- · Direct Interface with Common PWM Control ICs
- Pin Equivalent to DS0026/DS0056; TSC426
- Pb-Free Available (RoHS Compliant)

Applications

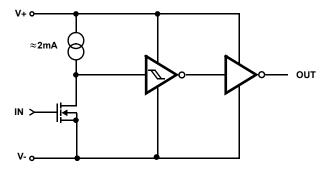
- · Switching Power Supplies
- · DC/DC Converters
- · Motor Controllers

Pinout

ICL7667 (8 LD PDIP, SOIC) TOP VIEW



Functional Diagram (Each Driver)



^{*}Pb-free PDIPs can be used for through hole wave solder processing only. They are not intended for use in Reflow solder processing applications.

Absolute Maximum Ratings

Supply Voltage V+ to V	
Input Voltage	V0.3V to V+ +0.3V
Package Dissipation, T _A +25°C	

Operating Conditions

ICL7667C	0° to +70°C
Supply Voltages: V+ = +4.5V to +15V; V- = Ground to -1	5V
Logic Inputs: Logic Low = V- < Vin < 0.8V; Logic High =	2.0V< Vin <
V+	

Thermal Information

Thermal Resistance (Typical, Note 1, 2)	θ _{JA} (°C/W)	θ _{JC} (°C/W)
8 Ld PDIP Package	150	N/A
8 Ld SOIC Package	170	N/A
Maximum Storage Temperature Range	6	5° to +150°C
Maximum Lead Temperature (Soldering 1	l0s)	300°C
(SOIC - Lead Tips Only)		
Pb-Free Reflow Profile		ee link below
http://www.intersil.com/pbfree/Pb-Freel	Reflow.asp	
Pb-free PDIPs can be used for through he	ole wave solde	er processing
only. They are not intended for use in	Reflow solde	r processing
applications.		

CAUTION: Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions may adversely impact product reliability and result in failures not covered by warranty.

NOTES:

- 1. θ_{JA} is measured with the component mounted on an evaluation PC board in free air.
- 2. For $\theta_{\mbox{\scriptsize JC}},$ the "case temp" location is the center of the exposed metal pad on the package underside.

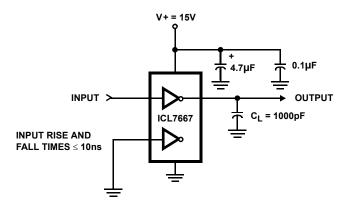
Electrical Specifications

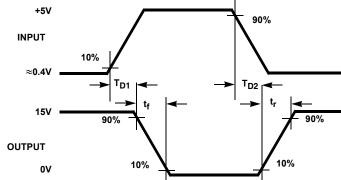
Parameters with MIN and/or MAX limits are 100% tested at +25°C, V+ = 0V unless otherwise specified. Temperature limits established by characterization and are not production tested.

			ICL7667C, M T _A = +25°C		ICL7667M					
					$0^{\circ}C \leq T_{\mbox{\scriptsize A}} \leq +70^{\circ}C$					
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	UNITS	
DC SPECIFICATIONS	DC SPECIFICATIONS									
Logic 1 Input Voltage	V _{IH}	V+ = 4.5V	2.0	-	-	2.0	-	-	V	
Logic 1 Input Voltage	V _{IH}	V+V+ = 15V	2.0	-	-	2.0	-	-	٧	
Logic 0 Input Voltage	V _{IL}	V+ = 4.5V	-	-	0.8	-	-	0.5	V	
Logic 0 Input Voltage	V _{IL}	V+ = 15V	-	-	8.0	-	-	0.5	٧	
Input Current	I _{IL}	V+ = 15V, V _{IN} = 0V and 15V	-0.1	-	0.1	-0.1	-	0.1	μΑ	
Output Voltage High	V _{OH}	V+ = 4.5V and 15V	V+ -0.05	V+	-	V+ -0.1	V+	-	V	
Output Voltage Low	V _{OL}	V+ = 4.5V and 15V	-	0	0.05	-	-	0.1	V	
Output Resistance	R _{OUT}	V _{IN} = V _{IL} , I _{OUT} = -10mA, V+ = 15V	-	7	10	-	-	12	Ω	
Output Resistance	R _{OUT}	V _{IN} = V _{IH} , I _{OUT} = 10mA, V+ = 15V	-	8	12	-	-	13	Ω	
Power Supply Current	I _{CC}	V+ = 15V, V _{IN} = 3V both inputs	-	5	7	-	-	8	mA	
Power Supply Current	Icc	V+ = 15V, V _{IN} = 0V both inputs	-	150	400	-	-	400	μA	
SWITCHING SPECIFICATIONS										
Delay Time	T _{D2}	(Figure 3)	-	35	50	-	-	60	ns	
Rise Time	T _R	(Figure 3)	-	20	30	-	-	40	ns	
Fall Time	T _F	(Figure 3)	-	20	30	-	-	40	ns	
Delay Time	T _{D1}	(Figure 3)	-	20	30	-	-	40	ns	

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Test Circuits





Typical Performance Curves

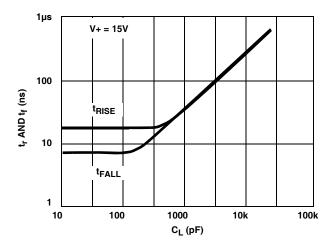


FIGURE 1. RISE AND FALL TIMES vs $\mathbf{C}_{\mathbf{L}}$

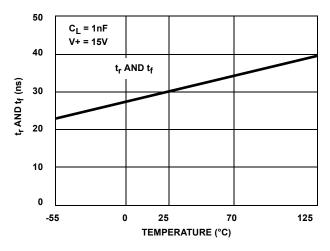


FIGURE 3. t_r , t_f vs TEMPERATURE

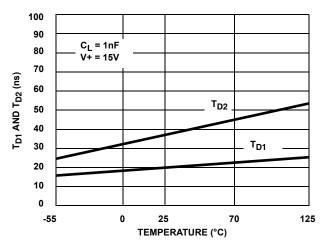


FIGURE 2. $\rm T_{D1}, \rm T_{D2} \, vs \, TEMPERATURE$

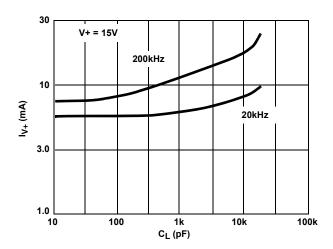


FIGURE 4. I_{V+} vs C_L

3

Typical Performance Curves (Continued)

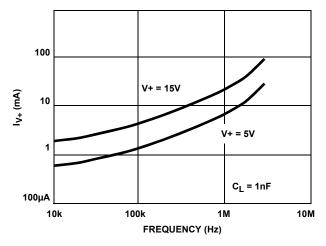


FIGURE 5. IV+ vs FREQUENCY

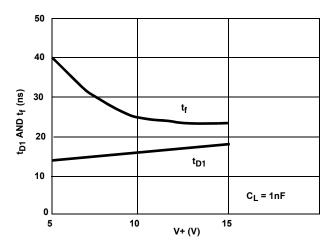


FIGURE 7. DELAY AND FALL TIMES vs V+

Detailed Description

The ICL7667 is a dual high-power CMOS inverter whose inputs respond to TTL levels while the outputs can swing as high as 15V. Its high output current enables it to rapidly charge and discharge the gate capacitance of power MOSFETs, minimizing the switching losses in switchmode power supplies. Since the output stage is CMOS, the output will swing to within millivolts of both V- and V+ without any external parts or extra power supplies as required by the DS0026/56 family. Although most specifications are at V+ = 15V, the propagation delays and specifications are almost independent of V+.

In addition to power MOS drivers, the ICL7667 is well suited for other applications such as bus, control signal, and clock drivers on large memory of microprocessor boards, where the load capacitance is large and low propagation delays are required. Other potential applications include peripheral power drivers and charge-pump voltage inverters.

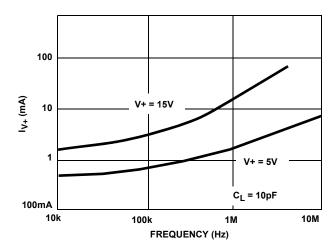


FIGURE 6. NO LOAD IV+ vs FREQUENCY

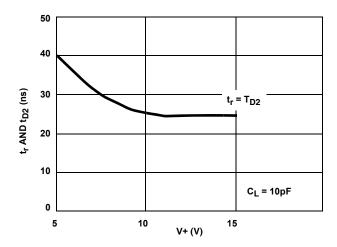


FIGURE 8. RISE TIME vs V+

Input Stage

The input stage is a large N-Channel FET with a P-Channel constant-current source. This circuit has a threshold of about 1.5V, relatively independent of the V+ voltage. This means that the inputs will be directly compatible with TTL over the entire 4.5V - 15V V+ range. Being CMOS, the inputs draw less than 1 μ A of current over the entire input voltage range of V- to V+. The quiescent current or no load supply current of the ICL7667 is affected by the input voltage, going to nearly zero when the inputs are at the 0 logic level and rising to 7mA maximum when both inputs are at the 1 logic level. A small amount of hysteresis, about 50mV to 100mV at the input, is generated by positive feedback around the second stage.

Output Stage

The ICL7667 output is a high-power CMOS inverter, swinging between V- and V+. At V+ = 15V, the output impedance of the inverter is typically 7Ω . The high peak

FN2853.6 April 29, 2010 current capability of the ICL7667 enables it to drive a 1000pF load with a rise time of only 40ns. Because the output stage impedance is very low, up to 300mA will flow through the series N-Channel and P-Channel output devices (from V+ to V-) during output transitions. This crossover current is responsible for a significant portion of the internal power dissipation of the ICL7667 at high frequencies. It can be minimized by keeping the rise and fall times of the input to the ICL7667 below 1µs.

Application Notes

Although the ICL7667 is simply a dual level-shifting inverter, there are several areas to which careful attention must be paid.

Grounding

Since the input and the high current output current paths both include the V- pin, it is very important to minimize and common impedance in the ground return. Since the ICL7667 is an inverter, any common impedance will generate negative feedback, and will degrade the delay, rise and fall times. Use a ground plane if possible, or use separate ground returns for the input and output circuits. To minimize any common inductance in the ground return, separate the input and output circuit ground returns as close to the ICL7667 as is possible.

Bypassing

The rapid charging and discharging of the load capacitance requires very high current spikes from the power supplies. A parallel combination of capacitors that has a low impedance over a wide frequency range should be used. A $4.7\mu F$ tantalum capacitor in parallel with a low inductance $0.1\mu F$ capacitor is usually sufficient bypassing.

Output Damping

Ringing is a common problem in any circuit with very fast rise or fall times. Such ringing will be aggravated by long inductive lines with capacitive loads. Techniques to reduce ringing include:

- Reduce inductance by making printed circuit board traces as short as possible.
- Reduce inductance by using a ground plane or by closely coupling the output lines to their return paths.
- Use a 10Ω to 30Ω resistor in series with the output of the ICL7667. Although this reduces ringing, it will also slightly increase the rise and fall times.
- Use good by-passing techniques to prevent supply voltage ringing.

Power Dissipation

The power dissipation of the ICL7667 has three main components:

1. Input inverter current loss

- 2. Output stage crossover current loss
- 3. Output stage I²R power loss

The sum of the above must stay within the specified limits for reliable operation.

As noted above, the input inverter current is input voltage dependent, with an I_{V+} of 0.1mA maximum with a logic 0 input and 6mA maximum with a logic 1 input.

The output stage crowbar current is the current that flows through the series N-Channel and P-Channel devices that form the output. This current, about 300mA, occurs only during output transitions. **Caution:** The inputs should never be allowed to remain between V_{IL} and V_{IH} since this could leave the output stage in a high current mode, rapidly leading to destruction of the device. If only one of the drivers is being used, be sure to tie the unused input to V- or ground. **NEVER** leave an input floating. The average supply current drawn by the output stage is frequency dependent, as can be seen in Figure 5 (I_{V+} vs Frequency graph in the Typical Characteristics Graphs).

The output stage I²R power dissipation is nothing more than the product of the output current times the voltage drop across the output device. In addition to the current drawn by any resistive load, there will be an output current due to the charging and discharging of the load capacitance. In most high frequency circuits the current used to charge and discharge capacitance dominates, and the power dissipation is approximately:

$$P_{AC} = CV_{V}2_{f}$$
 (EQ. 1)

where C = Load Capacitance, f = Frequency

In cases where the load is a power MOSFET and the gate drive requirement are described in terms of gate charge, the ICL7667 power dissipation will be:

$$P_{AC} = QGV_V f$$
 (EQ. 2)

where Q_G = Charge required to switch the gate, in Coulombs, f = Frequency.

Power MOS Driver Circuits

Power MOS Driver Requirements

Because it has a very high peak current output, the ICL7667 the at driving the gate of power MOS devices. The high current output is important since it minimizes the time the power MOS device is in the linear region. Figure 9 is a typical curve of Charge vs Gate voltage for a power MOSFET. The flat region is caused by the Miller capacitance, where the drain-to-gate capacitance is multiplied by the voltage gain of the FET. This increase in capacitance occurs while the power MOSFET is in the linear region and is dissipating significant amounts of power. The very high current output of the ICL7667 is able to rapidly

overcome this high capacitance and quickly turns the MOSFET fully on or off.

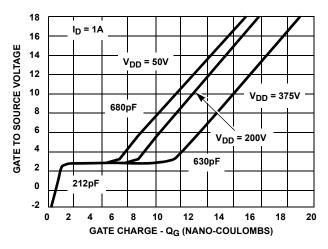


FIGURE 9. MOSFET GATE DYNAMIC CHARACTERISTICS

Direct Drive of MOSFETs

Figure 11 shows interfaces between the ICL7667 and typical switching regulator ICs. Note that unlike the DS0026, the ICL7667 does not need a dropping resistor and speedup capacitor between it and the regulator IC. The ICL7667, with its high slew rate and high voltage drive can directly drive the gate of the MOSFET. The SG1527 IC is the same as the

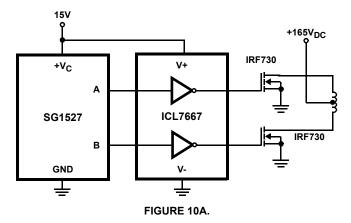
SG1525 IC, except that the outputs are inverted. This inversion is needed since ICL7667 is an inverting buffer.

Transformer Coupled Drive of MOSFETs

Transformers are often used for isolation between the logic and control section and the power section of a switching regulator. The high output drive capability of the ICL7667 enables it to directly drive such transformers. Figure 11 shows a typical transformer coupled drive circuit. PWM ICs with either active high or active low output can be used in this circuit, since any inversion required can be obtained by reversing the windings on the secondaries.

Buffered Drivers for Multiple MOSFETs

In very high power applications which use a group of MOSFETs in parallel, the input capacitance may be very large and it can be difficult to charge and discharge quickly. Figure 13 shows a circuit which works very well with very large capacitance loads. When the input of the driver is zero, Q_1 is held in conduction by the lower half of the ICL7667 and Q_2 is clamped off by Q_1 . When the input goes positive, Q_1 is turned off and a current pulse is applied to the gate of Q_2 by the upper half of the ICL7667 through the transformer, T_1 . After about 20ns, T_1 saturates and Q_2 is held on by its own C_{GS} and the bootstrap circuit of C_1 , D_1 and R_1 . This bootstrap circuit may not be needed at frequencies greater than 10kHz since the input capacitance of Q_2 discharges slowly.



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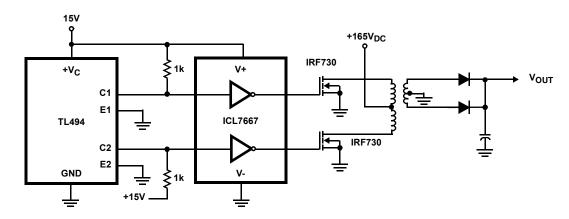


FIGURE 10B.
FIGURE 10. DIRECT DRIVE OF MOSFET GATES

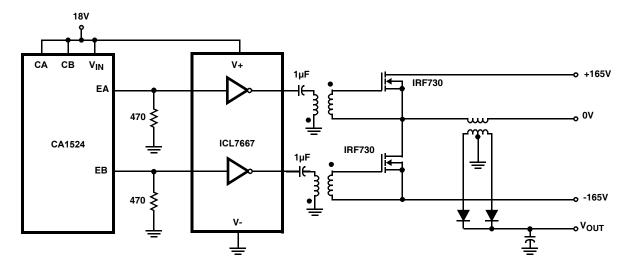


FIGURE 11. TRANSFORMER COUPLED DRIVE CIRCUIT

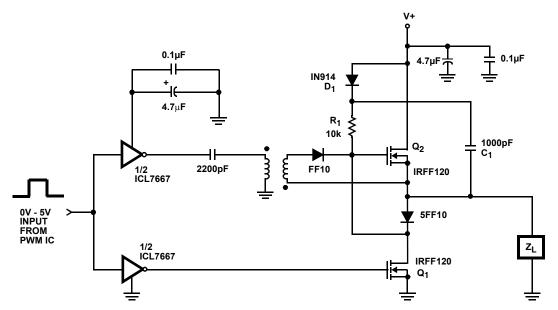
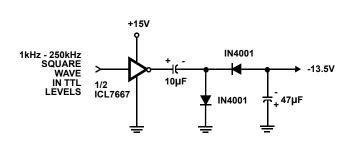


FIGURE 12. VERY HIGH SPEED DRIVER



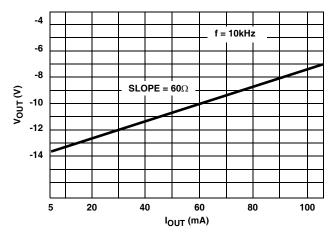


FIGURE 13A.

FIGURE 13B. OUTPUT CURRENT vs OUTPUT VOLTAGE

FIGURE 13. VOLTAGE INVERTER

Other Applications

Relay and Lamp Drivers

The ICL7667 is suitable for converting low power TTL or CMOS signals into high current, high voltage outputs for relays, lamps and other loads. Unlike many other level translator/driver ICs, the ICL7667 will both source and sink current. The continuous output current is limited to 200mA by the I²R power dissipation in the output FETs.

Charge Pump or Voltage Inverters and Doublers

The low output impedance and wide V+ range of the ICL7667 make it well suited for charge pump circuits. Figure 13A shows a typical charge pump voltage inverter circuit and a typical performance curve. A common use of this circuit is to provide a low current negative supply for analog circuitry or RS232 drivers. With an input voltage of +15V, this circuit will deliver 20mA at -12.6V. By increasing the size of the capacitors, the current capability can be increased and the voltage loss decreased. The practical range of the input frequency is 500Hz to 250kHz. As the frequency goes up, the charge pump capacitors can be made smaller, but the internal losses in the ICL7667 will rise, reducing the circuit efficiency.

Figure 14, a voltage doubler, is very similar in both circuitry and performance. A potential use of Figure 13 would be to supply the higher voltage needed for EEPROM or EPROM programming.

Clock Driver

Some microprocessors (such as the CDP68HC05 families) use a clock signal to control the various LSI peripherals of the family. The ICL7667s combination of low propagation delay, high current drive capability and wide voltage swing make it attractive for this application. Although the ICL7667 is primarily intended for driving power MOSFET gates at 15V, the ICL7667 also works well as a 5V high-speed buffer. Unlike standard 4000 series CMOS, the ICL7667 uses short channel length FETs and the ICL7667 is only slightly slower at 5V than at 15V.

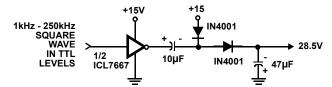
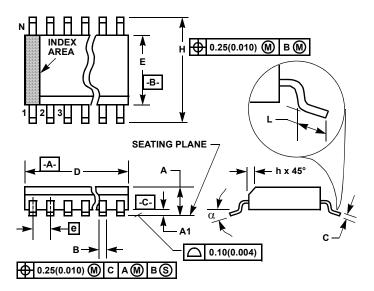


FIGURE 14. VOLTAGE DOUBLER

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Small Outline Plastic Packages (SOIC)



NOTES:

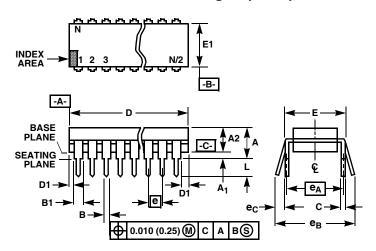
- Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication Number 95.
- 2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
- Dimension "D" does not include mold flash, protrusions or gate burrs. Mold flash, protrusion and gate burrs shall not exceed 0.15mm (0.006 inch) per side.
- Dimension "E" does not include interlead flash or protrusions. Interlead flash and protrusions shall not exceed 0.25mm (0.010 inch) per side
- 5. The chamfer on the body is optional. If it is not present, a visual index feature must be located within the crosshatched area.
- 6. "L" is the length of terminal for soldering to a substrate.
- 7. "N" is the number of terminal positions.
- 8. Terminal numbers are shown for reference only.
- The lead width "B", as measured 0.36mm (0.014 inch) or greater above the seating plane, shall not exceed a maximum value of 0.61mm (0.024 inch).
- Controlling dimension: MILLIMETER. Converted inch dimensions are not necessarily exact.

M8.15 (JEDEC MS-012-AA ISSUE C)
8 LEAD NARROW BODY SMALL OUTLINE PLASTIC PACKAGE

	INCHES		MILLIN		
SYMBOL	MIN	MAX	MIN	MAX	NOTES
Α	0.0532	0.0688	1.35	1.75	-
A1	0.0040	0.0098	0.10	0.25	-
В	0.013	0.020	0.33	0.51	9
С	0.0075	0.0098	0.19	0.25	-
D	0.1890	0.1968	4.80	5.00	3
Е	0.1497	0.1574	3.80	4.00	4
е	0.050 BSC		1.27 BSC		-
Н	0.2284	0.2440	5.80	6.20	-
h	0.0099	0.0196	0.25	0.50	5
L	0.016	0.050	0.40	1.27	6
N	8		8		7
α	0°	8°	0°	8°	-

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Dual-In-Line Plastic Packages (PDIP)



NOTES:

- Controlling Dimensions: INCH. In case of conflict between English and Metric dimensions, the inch dimensions control.
- 2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
- 3. Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication No. 95.
- Dimensions A, A1 and L are measured with the package seated in JEDEC seating plane gauge GS-3.
- D, D1, and E1 dimensions do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.010 inch (0.25mm).
- E and eA are measured with the leads constrained to be perpendicular to datum -C-.
- 7. e_B and e_C are measured at the lead tips with the leads unconstrained. e_C must be zero or greater.
- 8. B1 maximum dimensions do not include dambar protrusions. Dambar protrusions shall not exceed 0.010 inch (0.25mm).
- 9. N is the maximum number of terminal positions.
- Corner leads (1, N, N/2 and N/2 + 1) for E8.3, E16.3, E18.3, E28.3, E42.6 will have a B1 dimension of 0.030 - 0.045 inch (0.76 - 1.14mm).

E8.3 (JEDEC MS-001-BA ISSUE D) 8 LEAD DUAL-IN-LINE PLASTIC PACKAGE

	INCHES		MILLIM		
SYMBOL	MIN	MAX	MIN	MAX	NOTES
Α	-	0.210	-	5.33	4
A1	0.015	-	0.39	-	4
A2	0.115	0.195	2.93	4.95	-
В	0.014	0.022	0.356	0.558	-
B1	0.045	0.070	1.15	1.77	8, 10
С	0.008	0.014	0.204	0.355	-
D	0.355	0.400	9.01	10.16	5
D1	0.005	-	0.13	-	5
Е	0.300	0.325	7.62	8.25	6
E1	0.240	0.280	6.10	7.11	5
е	0.100 BSC		2.54 BSC		-
e _A	0.300 BSC		7.62 BSC		6
e _B	-	0.430	-	10.92	7
L	0.115	0.150	2.93	3.81	4
N	8	8		8	

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